

CMOS Digital Integrated Circuits Silicon Monolithic

74VHC9541FT

1. Functional Description

· Octal Universal Schmitt Buffer with 3-State Outputs

2. General

The 74VHC9541FT is an ultra-high-speed octal Schmitt buffer fabricated using silicon-gate CMOS technology. The 74VHC9541FT combines low power consumption of CMOS with Schottky TTL speeds.

The outputs can be put in the high-impedance state by placing a logic HIGH on the Enable (\overline{G}) input. The CONT input determines the logical inversion of data. A logic LOW on the CONT input configures the 74VHC9541FT as an inverter; a logic HIGH on the CONT input configures the 74VHC9541FT as a buffer.

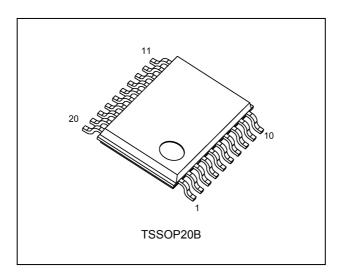
All the inputs have hysteresis between the positive-going and negative-going thresholds. Thus the 74VHC9541FT is capable of squaring up transitions of slowly changing input signals and provides an improved noise immunity. Additionally, all the inputs have a newly developed protection circuit without a diode returned to V_{CC} . This enables the inputs to be tolerant of up to 5 volts even when power supply is down. The input power-down protection capability makes the 74VHC9541FT ideal for a wide range of applications, such as interfacing between different voltages, voltage translation from 5~V to 3~V and battery back-up circuits.

3. Features

- (1) AEC-Q100 (Rev. H) (Note 1)
- (2) Wide operating temperature range: $T_{opr} = -40$ to 125 °C
- (3) High speed: tpd = 5.0 ns (typ.) at $V_{CC} = 5.0 \text{ V}$
- (4) Low supply current: I_{CC} = 4.0 μA (max) (T_a = 25 $^{\circ}$ C)
- (5) All inputs are provided with power-down protection.
- (6) Symmetrical rise and fall delays: t_{PLH} ≈ t_{PHL}
- (7) Wide operating voltage range: $V_{CC(opr)} = 2.0 \text{ V}$ to 5.5 V

Note 1: This device is compliant with the reliability requirements of AEC-Q100. For details, contact your Toshiba sales representative.

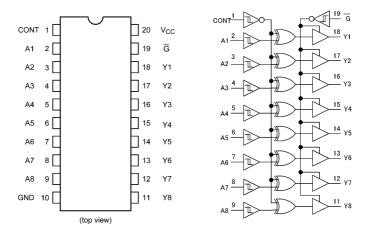
4. Packaging



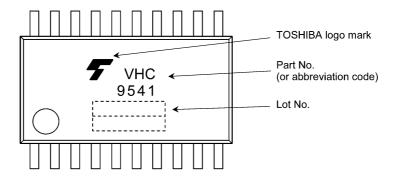
Start of commercial production



5. Pin Assignment



6. Marking



7. Truth Table

| Input G | Input CONT | Input An | Output Yn |
|---------|------------|----------|-----------|
| Н | Х | Х | Z |
| L | L | L | Н |
| L | L | Н | L |
| L | Н | L | L |
| L | Н | Н | Н |

X: Don't care

Z: High impedance

Rev.4.0



8. Absolute Maximum Ratings (Note)

| Characteristics | Symbol | Note | Rating | Unit |
|---------------------------------|------------------|----------|-------------------------------|------|
| Supply voltage | V _{CC} | | -0.5 to 7.0 | V |
| Input voltage | V _{IN} | | -0.5 to 7.0 | V |
| Output voltage | V _{out} | | -0.5 to V _{CC} + 0.5 | V |
| Input diode current | I _{IK} | | -20 | mA |
| Output diode current | I _{OK} | | ±20 | mA |
| Output current | I _{OUT} | | ±25 | mA |
| V _{CC} /ground current | I _{CC} | | ±75 | mA |
| Power dissipation | P _D | (Note 1) | 180 | mW |
| Storage temperature | T _{stg} | | -65 to 150 | °C |

Note: Exceeding any of the absolute maximum ratings, even briefly, lead to deterioration in IC performance or even destruction.

Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings and the operating ranges.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

Note 1: 180 mW in the range of T_a = -40 to 85 °C. From T_a = 85 to 125 °C a derating factor of -3.25 mW/°C shall be applied until 50 mW.

9. Operating Ranges (Note)

| Characteristics | Symbol | Rating | Unit |
|-----------------------|------------------|----------------------|------|
| Supply voltage | V _{CC} | 2.0 to 5.5 | V |
| Input voltage | V _{IN} | 0 to 5.5 | V |
| Output voltage | V _{OUT} | 0 to V _{CC} | V |
| Operating temperature | T _{opr} | -40 to 125 | °C |

Note: The operating ranges must be maintained to ensure the normal operation of the device. Unused inputs must be tied to either V_{CC} or GND.



10. Electrical Characteristics

10.1. DC Characteristics (Unless otherwise specified, T_a = 25 °C)

| Characteristics | Symbol | Test Condition | | V _{CC} (V) | Min | Тур. | Max | Unit |
|--|-----------------|---|--------------------------|---------------------|------|------|-------|------|
| Positive threshold voltage | V_P | _ | | 3.0 | _ | _ | 2.20 | V |
| | | | | 4.5 | _ | _ | 3.15 | |
| | | | | 5.5 | _ | _ | 3.85 | |
| Negative threshold voltage | V _N | _ | | 3.0 | 0.90 | _ | _ | V |
| | | | | 4.5 | 1.35 | _ | _ | |
| | | | | 5.5 | 1.65 | _ | | |
| Hysteresis voltage | V _H | _ | | 3.0 | 0.30 | _ | 1.20 | V |
| | | | | 4.5 | 0.40 | _ | 1.40 | |
| | | | | 5.5 | 0.50 | _ | 1.60 | |
| High-level output voltage | V _{OH} | V _{IN} = V _{IH} or V _{IL} | I _{OH} = -50 μA | 2.0 | 1.9 | 2.0 | _ | V |
| | | | | 3.0 | 2.9 | 3.0 | _ | |
| | | | | 4.5 | 4.4 | 4.5 | _ | |
| | | | I _{OH} = -4 mA | 3.0 | 2.58 | _ | _ | |
| | | | I_{OH} = -8 mA | 4.5 | 3.94 | _ | _ | |
| Low-level output voltage | V _{OL} | V _{IN} = V _{IH} or V _{IL} | I _{OL} = 50 μA | 2.0 | _ | 0.0 | 0.1 | V |
| | | | | 3.0 | _ | 0.0 | 0.1 | |
| | | | | 4.5 | _ | 0.0 | 0.1 | |
| | | | I _{OL} = 4 mA | 3.0 | _ | _ | 0.36 | |
| | | | I _{OL} = 8 mA | 4.5 | _ | _ | 0.36 | |
| 3-state output OFF-state leakage current | I _{OZ} | $V_{IN} = V_{IH} \text{ or } V_{IL}$ $V_{OUT} = V_{CC} \text{ or GND}$ | | 5.5 | _ | | ±0.25 | μА |
| Input leakage current | I _{IN} | V _{IN} = 5.5 V or GND | | 0 to 5.5 | | _ | ±0.1 | μΑ |
| Quiescent supply current | Icc | V _{IN} = V _{CC} or GND | | 5.5 | _ | _ | 4.0 | μА |



10.2. DC Characteristics (Unless otherwise specified, T_a = -40 to 85 °C)

| Characteristics | Symbol | Test Condition | | V _{CC} (V) | Min | Max | Unit |
|--|-----------------|---|--------------------------|---------------------|------|-------|------|
| Positive threshold voltage | V _P | _ | | 3.0 | _ | 2.20 | V |
| | | | | 4.5 | _ | 3.15 | |
| | | | | 5.5 | _ | 3.85 | |
| Negative threshold voltage | V _N | _ | | 3.0 | 0.90 | _ | V |
| | | | | 4.5 | 1.35 | _ | |
| | | | | 5.5 | 1.65 | _ | |
| Hysteresis voltage | V _H | _ | | 3.0 | 0.30 | 1.20 | V |
| | | | | 4.5 | 0.40 | 1.40 | |
| | | | | 5.5 | 0.50 | 1.60 | |
| High-level output voltage | V _{OH} | V _{IN} = V _{IH} or V _{IL} | I _{OH} = -50 μA | 2.0 | 1.9 | _ | V |
| | | | | 3.0 | 2.9 | _ | |
| | | | | 4.5 | 4.4 | _ | |
| | | | I _{OH} = -4 mA | 3.0 | 2.48 | _ | |
| | | | I _{OH} = -8 mA | 4.5 | 3.80 | _ | |
| Low-level output voltage | V _{OL} | V _{IN} = V _{IH} or V _{IL} | I _{OL} = 50 μA | 2.0 | _ | 0.1 | V |
| | | | | 3.0 | _ | 0.1 | |
| | | | | 4.5 | _ | 0.1 | |
| | | | I _{OL} = 4 mA | 3.0 | _ | 0.44 | |
| | | | I _{OL} = 8 mA | 4.5 | _ | 0.44 | |
| 3-state output OFF-state leakage current | I _{OZ} | $V_{IN} = V_{IH} \text{ or } V_{IL}$ $V_{OUT} = V_{CC} \text{ or GND}$ | | 5.5 | _ | ±2.50 | μА |
| Input leakage current | I _{IN} | V _{IN} = 5.5 V or GND | | 0 to 5.5 | _ | ±1.0 | μА |
| Quiescent supply current | I _{CC} | $V_{IN} = V_{CC}$ or GND | | 5.5 | | 40.0 | μА |



10.3. DC Characteristics (Unless otherwise specified, T_a = -40 to 125 °C)

| Characteristics | Symbol | Test Condition | | V _{CC} (V) | Min | Max | Unit |
|--|-----------------|---|--------------------------|---------------------|------|-------|------|
| Positive threshold voltage | V _P | _ | | 3.0 | _ | 2.20 | V |
| | | | | 4.5 | _ | 3.15 | |
| | | | | 5.5 | _ | 3.85 |] |
| Negative threshold voltage | V _N | _ | | 3.0 | 0.90 | _ | V |
| | | | | 4.5 | 1.35 | _ | |
| | | | | 5.5 | 1.65 | _ |] |
| Hysteresis voltage | V _H | _ | | 3.0 | 0.30 | 1.20 | V |
| | | | | 4.5 | 0.40 | 1.40 | |
| | | | | 5.5 | 0.50 | 1.60 |] |
| High-level output voltage | V _{OH} | V _{IN} = V _{IH} or V _{IL} | I _{OH} = -50 μA | 2.0 | 1.9 | _ | V |
| | | | | 3.0 | 2.9 | _ | |
| | | | | 4.5 | 4.4 | _ |] |
| | | | I _{OH} = -4 mA | 3.0 | 2.40 | _ | |
| | | | I _{OH} = -8 mA | 4.5 | 3.70 | _ | |
| Low-level output voltage | V _{OL} | V _{IN} = V _{IH} or V _{IL} | I _{OL} = 50 μA | 2.0 | _ | 0.1 | V |
| | | | | 3.0 | _ | 0.1 | |
| | | | | 4.5 | _ | 0.1 | |
| | | | I _{OL} = 4 mA | 3.0 | _ | 0.55 |] |
| | | | I _{OL} = 8 mA | 4.5 | _ | 0.55 | |
| 3-state output OFF-state leakage current | I _{OZ} | $V_{IN} = V_{IH} \text{ or } V_{IL}$ $V_{OUT} = V_{CC} \text{ or GND}$ | | 5.5 | _ | ±10.0 | μА |
| Input leakage current | I _{IN} | V _{IN} = 5.5 V or GND | | 0 to 5.5 | _ | ±2.0 | μА |
| Quiescent supply current | Icc | V _{IN} = V _{CC} or GND | | 5.5 | | 80.0 | μА |



10.4. AC Characteristics (Unless otherwise specified, $T_a = 25$ °C, Input: $t_r = t_f = 3$ ns)

| Characteristics | Symbol | Note | Test Condition | V _{CC} (V) | C _L (pF) | Min | Тур. | Max | Unit |
|-------------------------------|--------------------------------------|----------|-------------------------|---------------------|---------------------|-----|------|------|------|
| Propagation delay time | t _{PLH} ,t _{PHL} | | _ | 3.3 ± 0.3 | 15 | _ | 6.0 | 8.0 | ns |
| (An - Yn) | | | | | 50 | _ | 9.0 | 12.5 | |
| | | | | 5.0 ± 0.5 | 15 | | 5.0 | 5.5 | |
| | | | | | 50 | _ | 7.0 | 8.5 | |
| Propagation delay time | t _{PLH} ,t _{PHL} | | _ | 3.3 ± 0.3 | 15 | _ | 8.5 | 11.5 | ns |
| (CONT - Yn) | | | | | 50 | _ | 13.0 | 17.0 | |
| | | | | 5.0 ± 0.5 | 15 | _ | 6.5 | 8.0 | |
| | | | | | 50 | _ | 10.5 | 12.5 | |
| 3-state output enable time | t _{PZL} ,t _{PZH} | | $R_L = 1 k\Omega$ | 3.3 ± 0.3 | 15 | _ | 6.0 | 8.0 | ns |
| | | | | | 50 | _ | 10.5 | 13.5 | |
| | | | | 5.0 ± 0.5 | 15 | _ | 4.5 | 5.5 | |
| | | | | | 50 | _ | 9.0 | 10.5 | |
| 3-state output disable time | t_{PLZ}, t_{PHZ} | | $R_L = 1 k\Omega$ | 3.3 ± 0.3 | 50 | _ | 12.5 | 13.5 | ns |
| | | | | 5.0 ± 0.5 | 50 | _ | 9.0 | 9.5 | |
| Output skew | t _{osLH} ,t _{osHL} | (Note 1) | _ | 3.3 ± 0.3 | 50 | _ | _ | 1.5 | ns |
| | | | | 5.0 ± 0.5 | 50 | _ | _ | 1.0 | |
| Input capacitance | C _{IN} | | _ | | | _ | 4 | 10 | pF |
| Output capacitance | C _{OUT} | · | _ | | | _ | 6 | | pF |
| Power dissipation capacitance | C _{PD} | (Note 2) | f _{IN} = 1 MHz | | | _ | 11 | _ | pF |

Note 1: Parameter guaranteed by design. ($t_{osLH} = |t_{PLH}m - t_{PLH}n|$, $t_{osHL} = |t_{PHL}m - t_{PHL}n|$)

Note 2: C_{PD} is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption without load. Average operating current can be obtained by the equation. $I_{CC(opr)} = C_{PD} \times V_{CC} \times f_{|N} + I_{CC}/8 \text{ (per bit)}$

10.5. AC Characteristics (Unless otherwise specified, $T_a = -40$ to 85 °C, Input: $t_r = t_f = 3$ ns)

| Characteristics | Symbol | Note | Test Condition | V _{CC} (V) | C _L (pF) | Min | Max | Unit |
|-----------------------------|--------------------------------------|----------|-------------------|---------------------|---------------------|-----|------|------|
| Propagation delay time | t _{PLH} ,t _{PHL} | | _ | 3.3 ± 0.3 | 15 | 1.0 | 10.0 | ns |
| (An - Yn) | | | | | 50 | 1.0 | 15.0 | |
| | | | | 5.0 ± 0.5 | 15 | 1.0 | 7.0 | |
| | | | | | 50 | 1.0 | 10.0 | |
| Propagation delay time | t _{PLH} ,t _{PHL} | | _ | 3.3 ± 0.3 | 15 | 1.0 | 13.5 | ns |
| (CONT - Yn) | | | | | 50 | 1.0 | 20.5 | |
| | | | | 5.0 ± 0.5 | 15 | 1.0 | 9.5 | |
| | | | | | 50 | 1.0 | 15.0 | |
| 3-state output enable time | t _{PZL} ,t _{PZH} | | $R_L = 1 k\Omega$ | 3.3 ± 0.3 | 15 | 1.0 | 9.5 | ns |
| | | | | | 50 | 1.0 | 16.5 | |
| | | | | 5.0 ± 0.5 | 15 | 1.0 | 6.5 | |
| | | | | | 50 | 1.0 | 12.5 | |
| 3-state output disable time | t_{PLZ}, t_{PHZ} | | $R_L = 1 k\Omega$ | 3.3 ± 0.3 | 50 | 1.0 | 16.0 | ns |
| | | | | 5.0 ± 0.5 | 50 | 1.0 | 11.0 | |
| Output skew | t _{osLH} ,t _{osHL} | (Note 1) | _ | 3.3 ± 0.3 | 50 | _ | 1.5 | ns |
| | | | | 5.0 ± 0.5 | 50 | | 1.0 | |
| Input capacitance | C _{IN} | | _ | • | | _ | 10 | pF |

Note 1: Parameter guaranteed by design. ($t_{osLH} = |t_{PLH}m - t_{PLH}n|$, $t_{osHL} = |t_{PHL}m - t_{PHL}n|$)

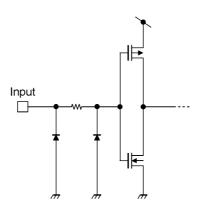


10.6. AC Characteristics (Unless otherwise specified, $T_a = -40$ to 125 °C, Input: $t_r = t_f = 3$ ns)

| Characteristics | Symbol | Note | Test Condition | V _{CC} (V) | C _L (pF) | Min | Max | Unit |
|-----------------------------|--------------------------------------|----------|-------------------|---------------------|---------------------|-----|------|------|
| Propagation delay time | t _{PLH} ,t _{PHL} | | _ | 3.3 ± 0.3 | 15 | 1.0 | 11.5 | ns |
| (An - Yn) | | | | | 50 | 1.0 | 17.0 | |
| | | | | 5.0 ± 0.5 | 15 | 1.0 | 8.0 | |
| | | | | | 50 | 1.0 | 11.0 | |
| Propagation delay time | t _{PLH} ,t _{PHL} | | _ | 3.3 ± 0.3 | 15 | 1.0 | 15.0 | ns |
| (CONT - Yn) | | | | | 50 | 1.0 | 23.0 | |
| | | | | 5.0 ± 0.5 | 15 | 1.0 | 10.5 | |
| | | | | | 50 | 1.0 | 17.0 | |
| 3-state output enable time | t_{PZL}, t_{PZH} | | $R_L = 1 k\Omega$ | 3.3 ± 0.3 | 15 | 1.0 | 10.5 | ns |
| | | | | | 50 | 1.0 | 18.5 | |
| | | | | 5.0 ± 0.5 | 15 | 1.0 | 7.5 | |
| | | | | | 50 | 1.0 | 14.0 | |
| 3-state output disable time | t_{PLZ}, t_{PHZ} | | $R_L = 1 k\Omega$ | 3.3 ± 0.3 | 50 | 1.0 | 18.0 | ns |
| | | | | 5.0 ± 0.5 | 50 | 1.0 | 12.0 | |
| Output skew | t _{osLH} ,t _{osHL} | (Note 1) | | 3.3 ± 0.3 | 50 | _ | 1.5 | ns |
| | | | | 5.0 ± 0.5 | 50 | _ | 1.0 | |
| Input capacitance | C _{IN} | | _ | | | _ | 10 | pF |

Note 1: Parameter guaranteed by design. ($t_{OSLH} = |t_{PLH}m - t_{PLH}n|$, $t_{OSHL} = |t_{PHL}m - t_{PHL}n|$)

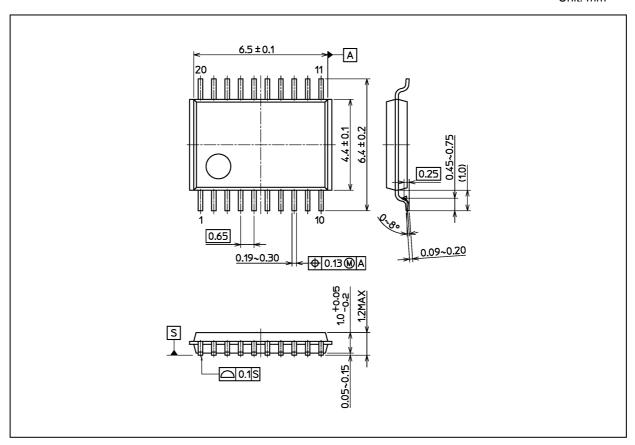
11. Internal Equivalent Circuit





Package Dimensions

Unit: mm



Weight: 0.071 g (typ.)

| | Package Name(s) |
|--------------------|-----------------|
| Nickname: TSSOP20B | |



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